

Search Notes



Application/Control No.

10/618,816

Examiner

Vuthe Siek

Applicant(s)/Patent under Reexamination

PANG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	4-6, 19-21	5/4/2005	VS
703	13	5/4/2005	VS
702	59,81	5/4/2005	VS
430	5	5/4/2005	VS
382	144,145	5/4/2005	VS
382	149	5/4/2005	VS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	19,21	3/17/06	VS
see Interference Search History Printout		3/17/06	VS

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST ALL DATABASES, IEEE, GOOGLE	5/4/2005	VS
EAST all database See Search History Printouts	9/9/05 9/12/05	VS
Updated search See Search History Printout	3/17/06	VS